



Bruker **AXS** Inc.

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FOR IMMEDIATE RELEASE

Bruker AXS Introduces the *SI SORTER*™, an Affordable Handheld XRF Alloy Analyzer

CHICAGO, Illinois -- March 9, 2009 – At Pittcon® 2009, Bruker AXS introduces the *SI SORTER* as a rugged, easy-to-use and affordable handheld XRF alloy analyzer, which provides true point-and-shoot alloy identification and elemental composition. The *SI SORTER* was designed primarily for common alloys in the steel, cobalt, nickel, copper and titanium families. Its standard empirical calibrations provide fast and accurate analysis of these alloys while the optional Fundamental Parameters (FP) calibration allows the analysis of more exotic alloys. The *SI SORTER* provides a large grade library for alloy ID along with the capabilities to store and transfer the data for report generation.



Dr. John Patterson, Bruker's Director of Marketing & Product Management for handheld XRF, explained: "The *SI SORTER* was designed to meet the basic needs of the market for a rugged analyzer, which provides truly point-and-shoot analysis at a very attractive price point. In the business-critical area of handheld XRF technology, Bruker aims not only to be the best, but also to deliver the best value. Our *SI SORTER* is the ideal solution for customers looking to compete in these tough economic times. It delivers performance equal to any handheld XRF system using a SiPIN detector, but at a price significantly less than equivalents on the market."

For Further Information:

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